Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexamination 10/785,673 MINETTI ET AL. Examiner Art Unit Page 1 of 1 S. Devi, Ph.D. 1645

U.S. PATENT DOCUMENTS

	Old Fitter Decometry						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
	Α	US-					
	В	US-					
	С	US-					
	D	US-					
	Е	US-					
	F	US-					
	G	US-		-			
	Н	US-		-			
	T	US-					
	J	US-					
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

NOTE ATENT DOCUMENTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Lock et al. Microbial Pathogenesis 21: 71-83, 1996				
	v	Paton et al. Infect. Immun. 54: 50-55, 1986				
	w	Walker et al. Infect. Immun. 55: 1184-1189, 1987				
	x					

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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